


<b>Search Notes</b> 	<b>Application/Control No.</b> 10730657	<b>Applicant(s)/Patent Under Reexamination</b> MEEK ET AL.
	<b>Examiner</b> Asfand M Sheikh	<b>Art Unit</b> 3627

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SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search Updated (see attached)	7/31/2010	/ ams /

INTERFERENCE SEARCH			
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